

<b>Search Notes</b>	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10540311	AUGUSTUS ET AL.
Examiner	Art Unit	
Young J Kim	1637	

### SEARCHED

Class	Subclass	Date	Examiner

### SEARCH NOTES

Search Notes	Date	Examiner
re-reviewed the STIC-assisted search of SEQ ID Numbers 1 and 7	5/29/2009	/YJK/

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

	/Young J Kim/ Primary Examiner, Art Unit 1637
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